

Search Notes

Application/Control No.

10/849,186

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

WATANABE ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
430	270.1	6/2006	JSC
430	170		
430	905		
430	920		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
430	270.1	6/2006	JSC
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
UPDATED	6/2006	JSC